





#### **40V P-CHANNEL ENHANCEMENT MODE MOSFET**

#### **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C (Notes 6)
-40V	$25m\Omega$ @ $V_{GS} = -10V$	-8.6A
-40 V	45mΩ @ V <sub>GS</sub> = -4.5V	-7.0A

### **Description**

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

- Motor control
- Backlighting
- DC-DC Converters
- Printer equipment

#### **Features**

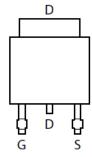
- Low On-Resistance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

#### **Mechanical Data**

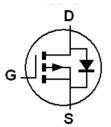
- Case: TO252 (DPAK)
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See diagram below
- Terminals: Finish Matte Tin annealed over Copper lead frame.
   Solderable per MIL-STD-202, Method 208 3
- Weight: 0.315 grams (approximate)



Top View



Top View Pin Out



Device symbol

#### **Ordering Information** (Note 4)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMP4025LK3-13	P4025L	13	12	2.500

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen and Antimony free, "Green" and Lead-Free.
- 3. Halogen and Antimony free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com

## **Marking Information**



Oll = Manufacturer's Marking P4025L = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 10 = 2010) WW = Week (01 - 53)





#### Maximum Ratings (@T<sub>A</sub> = +25°C unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V <sub>DSS</sub>	-40	V
Gate-Source Voltage			V <sub>GSS</sub>	±20	
		(Notes 6)		-8.6	
Continuous Drain Current	V <sub>GS</sub> = -10V	$T_A = +70^{\circ}C \text{ (Notes 6)}$	Ι <sub>D</sub>	-6.9	_
		(Notes 5)		-6.7	
Pulsed Drain Current	$V_{GS} = -10V$	(Notes 7)	I <sub>DM</sub>	-35	Α
Continuous Source Current (Body diode) (Notes 7)		(Notes 7)	I <sub>S</sub>	-8.6	
Pulsed Source Current (Body diode) (Notes 7)		(Notes 7)	I <sub>SM</sub>	-35	

## Thermal Characteristics (@T<sub>A</sub> = +25°C unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Dawar Dissipation	(Notes 5)		1.7	W	
Power Dissipation	(Notes 6)	P <sub>D</sub>	2.78	VV	
Thermal Decistores, Junction to Ambient	(Notes 5)	R <sub>θJA</sub>	74		°C/W
Thermal Resistance, Junction to Ambient	(Notes 6)		45		
Thermal Resistance, Junction to Lead (Notes 8)		$R_{ heta JL}$	1.43		
Operating and Storage Temperature Range		$T_{J}, T_{STG}$	-55 to +150	°C	

Notes:

- 5. For a device surface mounted on minimum recommended FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

  6. Same as note (5), except the device is surface mounted on 25mm X 25mm X 1.6mm FR4 PCB.

  7. Repetitive rating on 25mm X 25mm FR4 PCB, D=0.02, pulse width 300µs – pulse width by maximum junction temperature.

  8. Thermal resistance from junction to solder-point (at the end of the drain lead).



#### **Thermal Characteristics**

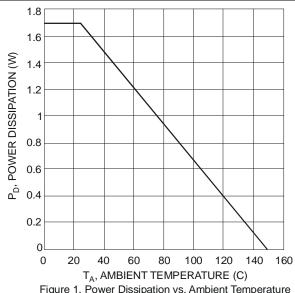
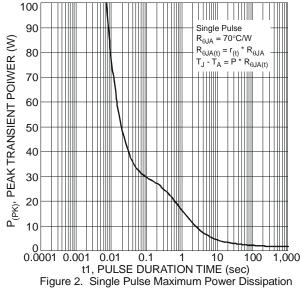


Figure 1. Power Dissipation vs. Ambient Temperature



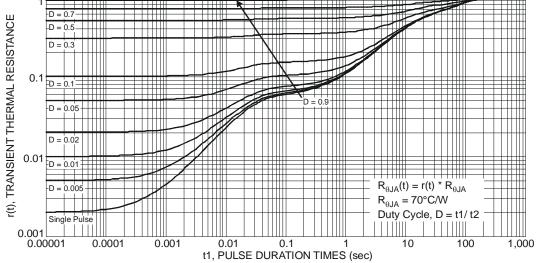


Figure 3. Transient Thermal Resistance



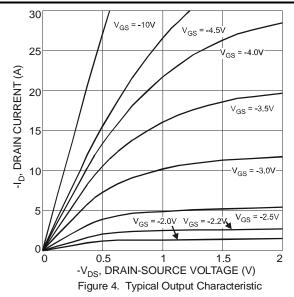
# Electrical Characteristics (@T<sub>A</sub> = +25°C unless otherwise specified.)

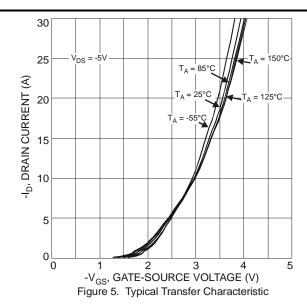
Characteristic	Symbol	Min	Тур	Max	Unit	Test Co	ndition	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-40	_	_	V	$I_D = -250 \mu A, V_{GS} = 0 V$		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1.0	μΑ	V <sub>DS</sub> = -40V, V <sub>GS</sub> = 0V		
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$		
ON CHARACTERISTICS					•	•		
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.8	-1.3	-1.8	V	$I_D = -250 \mu A, V_{DS} = -250 \mu A$	= V <sub>G</sub> S	
Static Drain Source On Registence (Note 0)	5		18	25	0	$V_{GS} = -10V, I_D = -3A$		
Static Drain-Source On-Resistance (Note 9)	R <sub>DS (ON)</sub>		30	45	mΩ	$V_{GS} = -4.5V, I_{D} = -4.5V$	-3A	
Forward Transconductance (Notes 9 & 10)	9fs	_	16.6		S	$V_{DS} = -5V, I_{D} = -3$	A	
Diode Forward Voltage (Note 9)	$V_{SD}$	_	-0.7	-1.0	V	I <sub>S</sub> = -1A, V <sub>GS</sub> = 0V		
DYNAMIC CHARACTERISTICS (Note 10)								
Input Capacitance	C <sub>iss</sub>	_	1643	_		pF V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V f = 1MHz		
Output Capacitance	Coss	_	179	_	pF			
Reverse Transfer Capacitance	C <sub>rss</sub>	_	128	_		I = IIVIMZ	= IIVIDZ	
Gate Resistance	Rg	_	6.43		Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$		
Total Gate Charge (Note 11)	Qg	_	14.0	_		$V_{GS} = -4.5V$		
Total Gate Charge (Note 11)	Qq	_	33.7	_			$V_{DS} = -20V$	
Gate-Source Charge (Note 11)	$Q_{gs}$	_	5.5	_	nC	$V_{GS} = -10V$ $I_D = -3A$	$I_D = -3A$	
Gate-Drain Charge (Note 11)	$Q_{gd}$	_	7.3	_				
Turn-On Delay Time (Note 11)	t <sub>D(on)</sub>	_	6.9			V <sub>DD</sub> = -20V, V <sub>GS</sub> = -10V		
Turn-On Rise Time (Note 11)	t <sub>r</sub>	_	14.7	_				
Turn-Off Delay Time (Note 11)	t <sub>D(off)</sub>	_	53.7	_	$\begin{array}{c c} - & \text{ns} & I_D = -3A \end{array}$			
Turn-Off Fall Time (Note 11)	t <sub>f</sub>	_	30.9	_				

Notes:

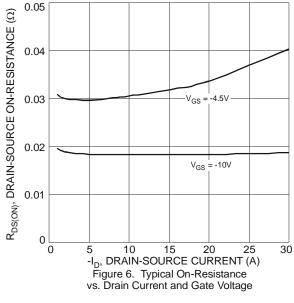
- 9. Measured under pulsed conditions. Pulse width  $\leq 300 \mu s;$  duty cycle  $\leq 2\%.$
- 10. For design aid only, not subject to production testing.11. Switching characteristics are independent of operating junction temperatures.

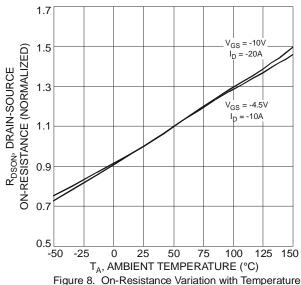
## **Typical Characteristics**











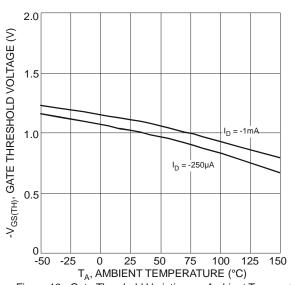
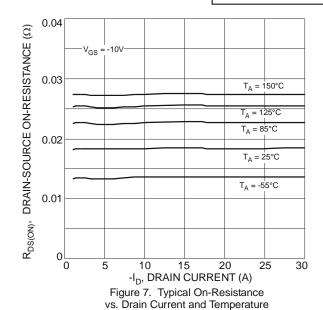


Figure 10. Gate Threshold Variation vs. Ambient Temperature



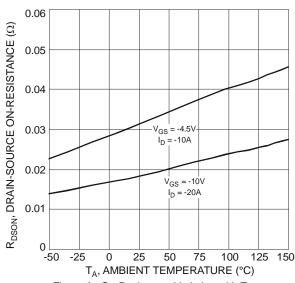


Figure 9. On-Resistance Variation with Temperature

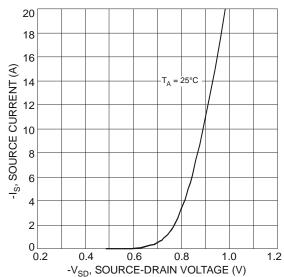
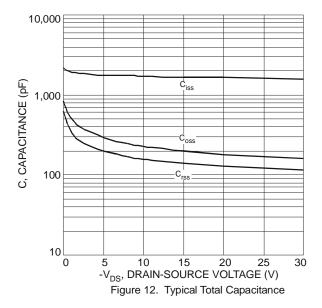
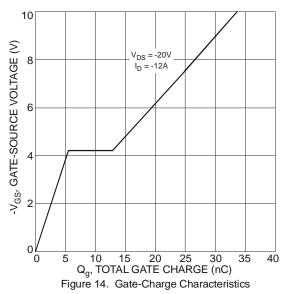
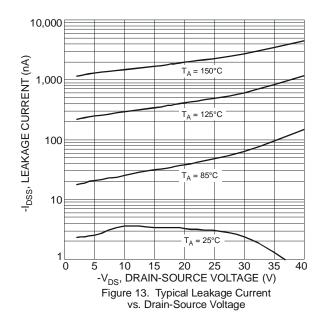


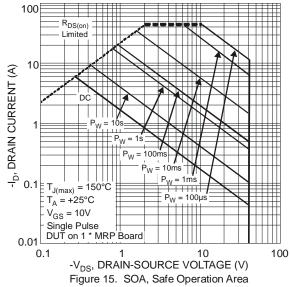
Figure 11. Diode Forward Voltage vs. Current





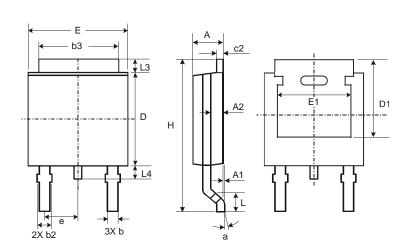






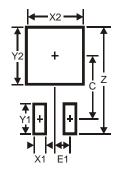


# **Package Outline Dimensions**



TO252					
Dim	Min	Max	Тур		
Α	2.19	2.39	2.29		
A1	0.00	0.13	0.08		
A2	0.97	1.17	1.07		
b	0.64	0.88	0.783		
b2	0.76	1.14	0.95		
b3	5.21	5.46	5.33		
c2	0.45	0.58	0.531		
D	6.00	6.20	6.10		
D1	5.21	_	_		
е	_	_	2.286		
Е	6.45	6.70	6.58		
E1	4.32	_	_		
Н	9.40	10.41	9.91		
L	1.40	1.78	1.59		
L3	0.88	1.27	1.08		
L4	0.64	1.02	0.83		
а	0°	10°	_		
All Dimensions in mm					

# **Suggested Pad Layout**



Dimensions	Value (in mm)		
Z	11.6		
X1	1.5		
X2	7.0		
Y1	2.5		
Y2	7.0		
С	6.9		
E4	2.2		





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